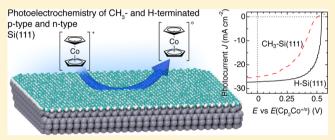
Comparison of the Photoelectrochemical Behavior of H-Terminated and Methyl-Terminated Si(111) Surfaces in Contact with a Series of One-Electron, Outer-Sphere Redox Couples in CH₃CN

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Supporting Information

ABSTRACT: The photoelectrochemical behavior of methylterminated p-type and n-type Si(111) surfaces was determined in contact with a series of one-electron, outer-sphere, redox couples that span >1 V in the Nernstian redox potential, $E(A/A^-)$, of the solution. The dependence of the current vs potential data, as well as of the open-circuit photovoltage, V_{oc} , on $E(A/A^-)$ was compared to the behavior of H-terminated ptype and n-type Si(111) surfaces in contact with these same electrolytes. For a particular $E(A/A^-)$ value, CH₃-terminated p-Si(111) electrodes showed lower V_{oc} values than H-



p-Si(111) electrodes showed lower V_{oc} values than Hterminated p-Si(111) electrodes, whereas CH₃-terminated n-Si(111) electrodes showed higher V_{oc} values than H-terminated n-Si(111) electrodes. Under 100 mW cm⁻² of ELH-simulated Air Mass 1.5 illumination, n-type H–Si(111) and CH₃–Si(111) electrodes both demonstrated nonrectifying behavior with no photovoltage at very negative values of $E(A/A^-)$ and produced limiting V_{oc} values of >0.5 V at very positive values of $E(A/A^-)$. Illuminated p-type H–Si(111) and CH₃–Si(111) electrodes produced no photovoltage at positive values of $E(A/A^-)$ and produced limiting V_{oc} values in excess of 0.5 V at very negative values of $E(A/A^-)$. In contact with CH₃CN-octamethylferrocene^{+/0}, differential capacitance vs potential experiments yielded a -0.40 V shift in flat-band potential for CH₃-terminated n-Si(111) surfaces relative to H-terminated n-Si(111) surfaces. Similarly, in contact with CH₃CN-1,1'-dicarbomethoxycobaltocene^{+/0}, the differential capacitance vs potential data indicated a -0.25 V shift in the flat-band potential for CH₃-terminated p-Si(111) electrodes relative to H-terminated p-Si(111) electrodes. The observed trends in V_{oc} vs $E(A/A^-)$, and the trends in the differential capacitance vs potential data indicated a -0.25 V shift in the interfacial dipole as a result of methylation of the Si(111) surface. The negative dipole shift is consistent with a body of theoretical and experimental comparisons of the behavior of CH₃–Si(111) surfaces vs H–Si(111) surfaces, including density functional theory of the sign and magnitude of the surface dipole, photoemission spectroscopy in ultrahigh vacuum, the electrical behavior of Hg/Si contacts, and the pH dependence of the current–potential behavior of Si electrodes in contact with aqueous electrolytes.

I. INTRODUCTION

To use semiconductor/liquid contacts for photoelectrochemical water splitting, the band-edge potentials must be favorably positioned relative to the formal potentials of the fuel-forming reactions, to ensure that the half-reactions for H_2 evolution and O_2 evolution are allowed thermodynamically under standard conditions.^{1,2} Many semiconductors, such as TiO₂ and WO₃, can produce the required photovoltage, but one (or both) of the band-edge positions of such materials are not properly positioned to thermodynamically effect water splitting in the absence of an externally applied bias voltage.¹ Hence, methods to manipulate, and to control chemically, the band-edge positions at semiconductor/liquid interfaces are of interest.

Silicon is one semiconductor of interest, primarily for use as a photocathode.³ Cathodic protection of Si would minimize the oxidatively driven formation of electrically insulating SiO_r

overlayers.³ Si(111) surfaces provide nearly ideal systems for the exploration of band-edge manipulation derived from chemical functionalization methods, due to the well-defined chemical and structural properties of the H-terminated Si(111) surface.⁴ Additionally, Si(111) surfaces can be functionalized with methyl groups through the use of a two-step chlorination/ alkylation process to produce well-ordered, chemically welldefined, $CH_3-Si(111)$ surfaces.⁴⁻¹¹ Such surfaces have essentially complete coverage of Si–C bonds on an unreconstructed Si(111) surface. $CH_3-Si(111)$ surfaces have been characterized by X-ray photoelectron spectroscopy,^{8,9,12,13} scanning tunneling spectroscopy,¹⁰ infrared vibrational spec-

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$ \begin{array}{c c c c c c c c c c c c c c c c c c c $		e^{poten} $E^{o'}(\text{Fc}^{+})$	potentials vs $E^{0'}(Fc^{+/0})$ (V)	concentrations (mM)	rations M)	effective potent	effective potentials vs SCE (V)		$V_{\rm oc}$ under 100 mW o	$V_{\rm oc}$ under 100 mW cm ⁻² illumination (V)	<i>(1</i>
$ \begin{array}{llllllllllllllllllllllllllllllllllll$		$E(A/A^-)$	$E^{o'}$ (A/A^-)	хo	red	$E_{\rm eff}(A/A^-)$ for p-Si		p-type H–Si(111)	p-type CH ₃ -Si(111)	n-type H-Si(111)	p-type CH ₃ -Si(111) n-type H-Si(111) n-type CH ₃ -Si(111)
cobaltocene ^{+/0} Cp ₂ Co ^{+/0} -0.867 -0.857 -0.857 -0.857 -0.857 -0.857 -0.857 -0.857 -0.857 -0.857 -0.857 -0.857 -0.857 -0.857 -0.720 methyl viologen ^{2+/++} MY ^{2+/+} -0.720 -0.948 -0.720 -0.940 -0.830 1.5 * -0.570 -0.940 -0.957 -0.317 (CpCO ₂ CH ₃) ₂ Co ^{+/0} -0.830 1.5 * -0.570 -0.940 -0.222 -0.570 -0.940 -0.227 (CpCO ₂ CH ₃) ₂ Co ^{+/0} -0.227 -0.222 -0.222 decomethylferrocene ^{+/0} CpS ₂ Fe ^{+/0} -0.124 -0.0122 -0.022 decomethylferrocene ^{+/0} CpS ₂ Fe ^{+/0} -0.124 -0.022 -0.022 decomethylferrocene ^{+/0} CpS ₂ Fe ^{+/0} -0.124 -0.022 -0.022 decomethylferrocene ^{+/0} CpS ₂ Fe ^{+/0} -0.022 -0.022 -0.022 -0.022 -0.022 -0.022 -0.022 -0.022 -0.022 -0.022 -0.022 decomethylferrocene ^{+/0} CpS ₂ Fe ^{+/0} -0.124 -0.022 -0.022	$^{\rm l}$ cobaltocene $^{+/0}$ Me $_2$ Cp $_2$ Co $^{+/0}$	-1.340	-1.410	54.9	*	-0.987	-1.003	0.578(21)	0.556(31)		
octamethylickeloceme ^{+/0} Me ₈ Cp ₂ Ni ^{+/0} -1.016 -0.990 7.4 18.3 -0.713 -0.720 methyl viologen ^{2+/+•} MV ^{2+/•} -0.830 -0.830 -0.830 1.5 * -0.570 -0.408 1.1'-dicarbonnethoxycyclopentadienylcobaltoceme ^{+/0} -0.672 -0.673 37.7 1.8 -0.327 $-0.317(CpC0_2CH_3)_2C0^{+/0} -0.82 -0.672 -0.763 37.7 1.8 -0.222 -0.222decamethylferroceme+/0 Cp2Ni+/0 -0.182 -0.148 -0.445 * 65.0 -0.182 -0.222decamethylferroceme+/0 Me8Cp2Fe+/0 -0.418 -0.448 12.1 0.8 -0.124 -0.042dimethylferroceme+/0 Me8Cp2Fe+/0 -0.182 -0.100 1.7 51.4 0.084 0.087dimethylferroceme+/0 Me2Cp2Fe+/0 -0.182 -0.100 1.7 51.4 0.084 0.087dimethylferroceme+/0 Cp2OCCH3)CpFe+/0 -0.182 -0.100 1.7 51.4 0.084 0.023dimethylferroceme+/0 CpCOCH3)CpFe+/0 -0.182 -0.100 1.7 51.4 0.084 0.023dimethylferroceme+/0 CpCOCH3)CpFe+/0 -0.182 -0.100 1.7 51.4 0.084 0.023dimethylferroceme+/0 CpCOCH3)CpFe+/0 -0.182 -0.100 1.7 51.4 0.034 0.0203dimethylferroceme+/0 CpCOCH3)CpFe+/0 -0.0153 0.261 * 5.4,9 0.040 0.026 0.226 0.203dimethylferroceme+/0 CpCOCH3)CpFe+/0 -0.0153 0.261 * 5.4,9 0.040 more of the species was generatedferroceme+/0 CpCOCH3)CpFe+/0 0.153 0.261 * 5.4,9 0.408 0.420dimethylferroceme+/0 CpCOCH3)CpFe+/0 0.153 more of the open-circuit photovoltage, V_{oJ} values and are C E_{eff}(A/A^-) values are tabulated relative to the potential of the saturated calomel electrode, SCE, as a dijusted by the experimentaCH3CN-1.0 M LiClO4. All of the V_{oc} values represent the average open-circuit photovoltage for multiple electrodes underCH3CN-1.0 M LiClO4. All of the V_{oc} values represent the average open-circuit photovoltage for multiple electrodes underCH3CN-1.0 M LiClO4. All of the Voc values represent the average open-circuit photovoltage for multiple electrodes underCH3CN-1.0 M LiClO4. All$	$ene^{+/0} Cp_2 Co^{+/0}$	-1.222	-1.331	54.6	1.2	-0.867	-0.857	0.538(40)	0.508(38)	0.005(7)	0.001(1)
methyl viologen ^{1+/+•} MV ^{2+/+•} – 0.830 –0.830 –0.890 1.5 * -0.570 –0.408 1,1'-dicarbomethoxycglopentadienylcobaltocene ^{+/0} –0.672 –0.673 37.7 1.8 –0.327 –0.317 (CpC0 ₂ CH ₃) ₂ C0 ^{+/0} nickelocene ^{+/0} Cp ₂ Ni ^{+/0} – 0.485 1.2.1 0.8 –0.182 –0.222 decamethylferrocene ^{+/0} Me ₈ Cp ₂ Fe ^{+/0} –0.418 –0.468 1.2.1 0.8 –0.124 –0.042 octamethylferrocene ^{+/0} Me ₈ Cp ₂ Fe ^{+/0} –0.182 –0.100 1.7 51.4 0.084 0.087 dimethylferrocene ^{+/0} Me ₈ Cp ₂ Fe ^{+/0} –0.182 –0.100 1.7 51.4 0.084 0.087 dimethylferrocene ^{+/0} Me ₂ Cp ₂ Fe ^{+/0} –0.182 –0.100 1.7 51.4 0.020 –0.008 dimethylferrocene ^{+/0} Me ₈ Cp ₂ Fe ^{+/0} –0.182 –0.100 1.7 51.4 0.020 –0.008 dimethylferrocene ^{+/0} Me ₂ Cp ₂ Fe ^{+/0} –0.182 –0.100 1.7 51.4 0.084 0.087 dimethylferrocene ^{+/0} CpCOCH ₃)CpFe ^{+/0} –0.153 0.261 * 5.4,0 0.026 0.203 acetylferrocene ^{+/0} (CpCOCH ₃)CpFe ^{+/0} 0.153 0.261 * 5.4,0 0.026 0.203 acetylferrocene ^{+/0} (CpCOCH ₃)CpFe ^{+/0} 0.153 0.261 * 5.4,0 0.048 0.0206 dimethylferrocene ^{+/0} (CpCOCH ₃)CpFe ^{+/0} 0.153 0.261 * 5.4,0 0.408 0.420 acetylferrocene ^{+/0} (CpCOCH ₃)CpFe ^{+/0} 0.153 0.261 * 5.4,0 0.408 0.420 dimethylferrocene ^{+/0} (CpCOCH ₃)CpFe ^{+/0} 0.153 0.261 * 5.4,0 0.408 0.420 dimethylferrocene ^{+/0} (CpCOCH ₃)CpFe ^{+/0} 0.153 0.261 * 5.4,0 0.408 0.420 dimethylferrocene ^{+/0} (CpCOCH ₃)CpFe ^{+/0} 0.153 0.261 * 5.4,0 0.408 0.420 dimethylferrocene ^{+/0} (CpCOCH ₃)CpFe ^{+/0} 0.153 0.261 * 5.4,0 0.408 0.420 dimethylferrocene ^{+/0} (CpCOCH ₃)CpFe ^{+/0} 0.160 0.17 * 0.445 * 5.4,0 0.408 0.420 dimethylferrocene ^{+/0} (CpCOCH ₃)CpFe ^{+/0} 0.160 0.161 * 5.4,0 0.408 0.420 dimethylferrocene ^{+/0} (CpCOCH ₃)CpFe ^{+/0} 0.160 0.17 * 5.4,0 0.448 * 0.088 0.420 dimethylferrocene ^{+/0} (CpCOCH ₃)CpFe ^{+/0} 0.161 * 0.051 * 5.4,0 0.408 0.420 dimethylferrocene ^{+/0} (CpCOCH ₃)CpFe ^{+/0} 0.161 * 0.051 * 0.201 * 0.408 0.420 * 0.420 * 0.420 * 0.420 * 0.420 * 0.440 * 0.	hylnickelocene ^{+/0} $Me_8Cp_2Ni^{+/0}$	-1.016	-0.990	7.4	18.3	-0.713	-0.720	0.501(30)	0.410(28)		0.030(10)
1,1'-dicarbomethoxycyclopentadienylcobaltocene ^{+/0} -0.572 -0.763 37.7 1.8 -0.327 -0.317 $(CpCO_2CH_3)_2Co^{+/0}$ $(CpCO_2CH_3)_2Co^{+/0}$ -0.490 -0.445 $*$ 65.0 -0.182 -0.222 nickelocene ^{+/0} Cp ₂ Ni ^{+/0} -0.490 -0.445 $*$ 65.0 -0.182 -0.222 decamethylferrocene ^{+/0} Me ₂ Cp ₂ Fe ^{+/0} -0.418 -0.466 $1.2.1$ 0.8 -0.124 -0.042 octamethylferrocene ^{+/0} Cp ₂ Fe ^{+/0} -0.122 -0.120 -0.008 -0.020 -0.008 dimethylferrocene ^{+/0} Cp ₂ Fe ^{+/0} $0.77^{+/0}$ -0.122 -0.122 -0.042 acetylferrocene ^{+/0} Cp ₂ Fe ^{+/0} $0.77^{+/0}$ -0.132 -0.100 1.7 51.4 0.087 dimethylferrocene ^{+/0} Cp ₂ Fe ^{+/0} 0.765 0.133 0.261 $*$ 54.9 0.408 0.420 acetylferrocene ^{+/0} CpCCCH ₃)CpFe ^{+/0} 0.153 0.261 $*$ 54.9 0.408 0.420 acetylferrocene ^{+/0} CpCCCH ₃)CpFe ^{+/0} 0.153 0.261 $*$ 54.9 0.408 0.420 acetylferrocene ^{+/0} CpCCCH ₃)CpFe ^{+/0} 0.153 0.261 $*$ 54.9 0.408 0.420 acetylferrocene ^{+/0} CpCCH ₃)CpFe ^{+/0} 0.153 0.261 $*$ 54.9 0.408 0.420 acetylferrocene ^{+/0} CpC-/0.100 1.7 54.9 0.408 0.420 5.67 0.420 acetylferrocene ^{+/0} CpC-/0.100 1.7 54.9 0.468	riologen ^{2+/+•} MV ^{2+/+•}	-0.830	-0.890	1.5	*	-0.570	-0.408	0.530(51)	0.310(31)	0.007(4)	0.102(17)
nickelocene ^{+/0} Cp ₂ Ni ^{+/0} -0.182 -0.490 -0.445 * 65.0 -0.182 -0.222 decamethylferrocene ^{+/0} Cp ₂ * ₂ Fe ^{+/0} -0.124 -0.042 octamethylferrocene ^{+/0} Me ₈ Cp ₂ Fe ^{+/0} -0.353 -0.406 $2.3.5$ 2.7 -0.020 -0.008 dimethylferrocene ^{+/0} Me ₈ Cp ₂ Fe ^{+/0} -0.182 -0.100 1.7 5.14 0.084 0.087 dimethylferrocene ^{+/0} Me ₂ Cp ₂ Fe ^{+/0} -0.182 -0.100 1.7 5.14 0.084 0.087 dimethylferrocene ^{+/0} (CpCOCH ₃)CpFe ^{+/0} -0.153 0.261 * 5.49 0.408 0.420 acceylferrocene ^{+/0} (CpCOCH ₃)CpFe ^{+/0} 0.153 0.261 * $5.4,9$ 0.408 0.420 acceylferrocene ^{+/0} (CpCOCH ₃)CpFe ^{+/0} 0.153 0.261 * $5.4,9$ 0.408 0.420 a The Nernstian redox cell potentials, $E(A/A^{-})$, and formal potentials, $E^{o}(A/A^{-})$, for each redox couple employed are reported 1.0 M LiClO ₄ . The solution concentrations are reported in mM except for solutions in which one of the species was generated solution potentials, $E_{\rm eff}(A/A^{-})$, are listed to facilitate intercomparison of the open-circuit photovoltage, $V_{o,o}$ values and are c $E_{\rm eff}(A/A^{-})$ values are tabulated relative to the potential of the saturated calomel electrode, SCE, as adjusted by the experimenta CH ₃ CN-1.0 M LiClO ₄ . All of the V_{oc} values represent the average open-circuit photovoltage for multiple electrodes under deviations in parentheses.	thomethoxycyclopentadienylcobaltocene $^{+/0}$ $ m D_2CH_3)_2Co^{+/0}$	-0.672	-0.763	37.7	1.8	-0.327	-0.317	0.447(48)	0.166(19)	0.015(11)	0.180(10)
decamethylferrocene ^{+/0} Cp [*] ₂ Fe ^{+/0} -0.418 -0.468 12.1 0.8 -0.124 -0.042 octamethylferrocene ^{+/0} Me ₅ Cp ₂ Fe ^{+/0} Me_5 Cp ₂ Fe ^{+/0} -0.353 -0.406 23.5 2.7 -0.020 -0.008 dimethylferrocene ^{+/0} Me ₅ Cp ₂ Fe ^{+/0} 0.5 Fe ^{+/0} -0.182 -0.100 1.7 51.4 0.084 0.087 ferrocene ^{+/0} Cp ₂ Fe ^{+/0} 0.5 Cp ₂ Fe ^{+/0} -0.182 -0.100 1.7 51.4 0.034 0.087 dimethylferrocene+/0 (CpCOCH ₃)CpFe ^{+/0} -0.182 -0.100 1.7 51.4 0.034 $0.020dimethylferrocene+/0$ (CpCOCH ₃)CpFe ^{+/0} 0.153 0.261 * 54.9 0.408 $0.420d^{-T}The Nernstian redox cell potentials, E(A/A^{-}), and formal potentials, E^{0}(A/A^{-}), for each redox couple employed are reported1.0 M LiClO4. The solution concentrations are reported in mM except for solutions in which one of the species was generatedsolution potentials, E_{eff}(A/A^{-}), are listed to facilitate intercomparison of the open-circuit photovoltage, V_{o,\sigma} values and are cE_{eff}(A/A^{-}) values are tabulated relative to the potential of the saturated calomel electrode, SCE, as adjusted by the experimentaCH3cCN-1.0 M LiClO4. All of the V_{oc} values represent the average open-circuit photovoltage for multiple electrodes underdeviations in parentheses.$	$ene^{+/0} Cp_2Ni^{+/0}$	-0.490	-0.445	*	65.0	-0.182	-0.222	0.261(54)	0.040(17)	0.120(20)	0.320(24)
octamethylferrocene ^{+/0} $Me_s Cp_2Fe^{+/0}$ -0.353 -0.406 23.5 2.7 -0.020 -0.008 dimethylferrocene ^{+/0} $Me_s Cp_2Fe^{+/0}$ 0.87 -0.182 -0.100 1.7 51.4 0.084 0.087 ferrocene ^{+/0} $Cp_2Fe^{+/0}$ 0.7 $Ec^{+/0}$ 0.055 0 4.5 $5.4.0$ 0.226 0.203 acceptiferrocene ^{+/0} $(CpCOCH_3)CpFe^{+/0}$ 0.153 0.261 $*$ $5.4.0$ 0.226 0.203 $acceptiferrocene^{+/0}$ $(CpCOCH_3)CpFe^{+/0}$ 0.153 0.261 $*$ 8.99 0.408 0.420 $acceptiferrocene^{+/0}$ $(LpCOCH_3)CpFe^{+/0}$ 0.153 0.261 $*$ 8.40 0.226 0.203 $acceptiferrocene^{+/0}$ $(LpCOCH_3)CpFe^{+/0}$ 0.420 $acceptiferrocene$ 0.153 0.261 $*$ 8.40 0.208 0.420 0.420 $acceptiferrocene e^{+/0} (LpCOCH_3) 2.00 0.420 0.420 1.0 M LiCIO_4. The solution concentrations are reported in mM except for solutions in which one of the species was generated solution potentials, E_{eff}(A/A^{-1}) are listed to facilitate intercomparison of the open-circuit photovoltage, V_{o,o} values and are C_{eff}(A/A^{-1}) values are tabulated relative to the potential of the saturated calomel electrode, SCE, as adjusted by the experimenta CH_3CN-1.0$ M $LiCIO_4$. All of the V_{oc} values represent the average open-circuit photovoltage for multiple electrodes under deviations in parentheses.	hylferrocene $^{+/0}$ Cp $^{*}{}_{2}$ Fe $^{+/0}$	-0.418	-0.468	12.1	0.8	-0.124	-0.042	0.294(25)	0.005(10)	0.111(11)	0.419(11)
dimethylferrocene ^{+/0} Me ₂ Cp ₂ Fe ^{+/0} -0.182 -0.182 -0.100 1.7 51.4 0.084 0.087 ferrocene ^{+/0} Cp ₂ Fe ^{+/0} , or Fc ^{+/0} $C_{P_2}Fe^{+/0}$, or Fc ^{+/0} -0.065 0 4.5 54.0 0.226 0.203 $acetylferrocene+/0 (CpCOCH3)CpFe+/0 -0.153 0.153 0.261 * 54.9 0.420 0.420 ^{aT}The Nernstian redox cell potentials, E(A/A^-), and formal potentials, E^{o'}(A/A^-), for each redox couple employed are reported 1.0 M LiClO4. The solution concentrations are reported in mM except for solutions in which one of the species was generated solution potentials, E_{eff}(A/A^-), are listed to facilitate intercomparison of the open-circuit photovoltage, V_{o,o} values and are C_{eff}(A/A^-) values are tabulated relative to the potential of the saturated calomel electrode, SCE, as adjusted by the experimenta CH3CN-1.0 M LiClO4. All of the V_{oc} values represent the average open-circuit photovoltage for multiple electrodes under deviations in parentheses.$	hylferrocene $^{+/0}$ Me $_8$ Cp $_2$ Fe $^{+/0}$	-0.353	-0.406	23.5	2.7	-0.020	-0.008	0.217(18)	0.010(8)	0.173(14)	0.452(30)
ferrocene ^{+/0} Cp ₂ Fe ^{+/0} , or Fc ^{+/0} -0.05 0 4.5 54.0 0.226 0.203 acetylferrocene ^{+/0} (CpCCH ₃)CpFe ^{+/0} 0.153 0.153 0.261 * 54.9 0.408 0.420 $^{-1}$ The Nernstian redox cell potentials, $E(A/A^-)$, and formal potentials, $E^{o'}(A/A^-)$, for each redox couple employed are reported 1.0 M LiClO ₄ . The solution concentrations are reported in mM except for solutions in which one of the species was generated solution potentials, $E_{eff}(A/A^-)$, and formal potentials, $E^{o'}(A/A^-)$, for each redox couple employed are reported 1.0 M LiClO ₄ . The solution concentrations are reported in mM except for solutions in which one of the species was generated be solution potentials, $E_{eff}(A/A^-)$, are listed to facilitate intercomparison of the open-circuit photovoltage, V_{oo} values and are c CH ₃ CN-1.0 M LiClO ₄ . All of the V_{oc} values reported the average open-circuit photovoltage for multiple electrodes under deviations in parentheses.	lferrocene ^{+/0} Me ₂ Cp ₂ Fe ^{+/0}	-0.182	-0.100	1.7	51.4	0.084	0.087	0.025(15)		0.341(25)	0.511(25)
acetylferrocene ^{4,0} (CpCOCH ₃)CpFe ^{4,0} 0.153 0.153 0.261 * 54.9 0.408 0.420 ^{ar} The Nernstian redox cell potentials, $E(A/A^-)$, and formal potentials, $E^o'(A/A^-)$, for each redox couple employed are reported 1.0 M LiClO ₄ . The solution concentrations are reported in mM except for solutions in which one of the species was generated solution potentials, $E_{eff}(A/A^-)$, are listed to facilitate intercomparison of the open-circuit photovoltage, V_{oo} values and are c $E_{eff}(A/A^-)$ values are tabulated relative to the potential of the saturated calomel electrode, SCE, as adjusted by the experimenta CH ₃ CN-1.0 M LiClO ₄ . All of the V_{oc} values represent the average open-circuit photovoltage for multiple electrodes under deviations in parentheses.	$e^{+/0}$ Cp ₂ Fe ^{+/0} , or Fc ^{+/0}	-0.065	0	4.5	54.0	0.226	0.203	0.015(13)		0.450(20)	0.520(29)
^{ar} The Nernstian redox cell potentials, $E(A/A^{-})$, and formal potentials, $E^{o'}(A/A^{-})$, for each redox couple employed are reported 1.0 M LiClO ₄ . The solution concentrations are reported in mM except for solutions in which one of the species was generated solution potentials, $E_{\text{eff}}(A/A^{-})$, are listed to facilitate intercomparison of the open-circuit photovoltage, $V_{o,o}$ values and are c $E_{\text{eff}}(A/A^{-})$ values are tabulated relative to the potential of the saturated calomel electrode, SCE, as adjusted by the experimenta $CH_3CN-1.0$ M LiClO ₄ . All of the V_{oc} values represent the average open-circuit photovoltage for multiple electrodes under deviations in parentheses.	rocene ^{+/0} (CpCOCH ₃)CpFe ^{+/0}	0.153	0.261	*	54.9	0.408	0.420			0.531(19)	0.539(30)
	ernstian redox cell potentials, $E(A/A^-)$, and $iClO_4$. The solution concentrations are rep potentials, $E_{\rm eff}(A/A^-)$, are listed to facilitz ι^-) values are tabulated relative to the poter -1.0 M LiClO ₄ . All of the $V_{\rm oc}$ values repu ns in parentheses.	I formal poten orted in mM (ate intercomp: ntial of the sati resent the ave	tials, $E^{o'}(A)$ except for a trison of the transform of transform of the transform of t	/A ⁻), foi solutions la open- mel elect circuit p	r each re i in whic circuit J trode, S(hotovol	edox couple em ch one of the si photovoltage, <i>V</i> CE, as adjusted tage for multip	pployed are repoid pecies was gener \int_{0}^{∞} values and a by the experime by the electrodes urbic electrodes under the sector of the secto	ted vs the ferrocen. ated in situ via bull re calculated based intally determined ider 100 mA cm ⁻²	ϵ formal potential E^{0} . t electrolysis, which ϵ on $E(A/A^{-})$ and th on version, $E^{0'}(Fc^{+/0})$ of ELH-type tungst	(ferrocene ^{+/0}), $E^{0'}$, are denoted by an i are concentrations of) = +0.311 V vs S(ten-halogen illumin	(Fc ^{+/0}), in CH ₃ CN– asterisk (*). Effective of redox species. The CE for ferrocene ^{+/0} in ation, with standard

Table 1. Summary of Experimental Conditions and Results^a

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troscopy,^{6,8} low-energy electron diffraction,¹³ temperature programmed desorption,⁸ and high-resolution electron-energy loss spectroscopy,¹⁴ among other techniques.⁶

In contact with ultrahigh vacuum (UHV), a combination of synchrotron-based soft X-ray photoelectron spectroscopy and ultraviolet photoelectron spectroscopy measurements indicated that the CH_3 -Si(111) surface had an interfacial dipole of -0.37 eV⁹, as compared to an interfacial dipole of +0.12 eV for the H-terminated Si(111) surface.¹⁵⁻¹⁷ Current density vs potential (J-E) and differential capacitance vs potential $(C_{diff}^{-2}-E)$ measurements with n-type Si indicated an increase in barrier height of ~0.55 eV for Hg/CH3-Si(111) junctions relative to Hg/H-Si(111) contacts at 300 K. Consistently, the barrier height for p-type Si surfaces decreased by >0.67 eV for CH₃-Si(111)/Hg contacts at 300 K relative to Hg/H-Si(111) contacts at 85 K. The direction and magnitude of the dipole on CH₃-Si(111) surfaces has also been investigated theoretically and is consistent with expectations based on the electronegativities of the Si, C and H species involved in the surface bonding.18

We report herein the magnitude and direction of band-edge shifts for various $CH_3-Si(111)/CH_3CN$ contacts, relative to the energetics of analogous $H-Si(111)/CH_3CN$ interfaces. Both *J*-*E* data and $C_{diff}^{-2}-E$ data were collected for a series of one-electron, outer-sphere, redox species that span a >1 V range in electrochemical potential, to compare systematically the photoelectrochemical behavior of n-type and p-type CH_3- Si(111) electrodes to that of n-type and p-type H-Si(111)electrodes.

II. EXPERIMENTAL SECTION

A. Chemicals and Silicon Wafers. Electrochemistry was performed in CH₃CN (99.8% anhydrous, Sigma-Aldrich) that contained lithium perchlorate (LiClO₄, 99.99% battery grade, Sigma Aldrich) as the supporting electrolyte. The CH₃CN was dried by use of a column of activated Al₂O₃. All 18 M Ω cm resistivity water was obtained from a Barnstead Nanopure system.

Prior to use, boron-doped, 0.24 Ω cm resistivity, p-type Si(111) (Addison Engineering, San Jose, California, with an acceptor density, $N_{\rm A} = 7.7 \times 10^{16} \text{ cm}^{-3}$), and phosphorusdoped, 1.5 Ω cm resistivity, n-type Si(111) (Silicon Inc., Boise, Idaho, with a donor density, $N_{\rm D} = 3.2 \times 10^{15} \text{ cm}^{-3}$) samples, both polished on one side and $381 \pm 25 \,\mu\text{m}$ thick, were diced into $\sim 2 \times 1$ cm pieces. The Si was sonicated and subsequently was rinsed in acetone (OmniSolv, EMD) followed by a rinse with isopropyl alcohol (ACS grade, EMD). The Si surfaces were then cleaned using an RCA SC-1 procedure followed by an SC-2 etch.¹⁹ Samples were etched for 10 s in a 6 M HF (aq) solution prepared by dilution of 49 wt % HF (aq) (semiconductor grade, Transene Company Inc., Danvers, Massachusetts) in H₂O. The Si samples were rinsed with copious amounts of H_2O and were dried in a stream of Ar (g). Silicon samples that were to be converted into CH_3 -Si(111) electrodes were etched further for 15 min in degassed 11 M (48 wt %) NH₄F (aq) (Transene Company Inc.) and then were transferred immediately to a flush box for surface methylation.

B. Surface Functionalization and Characterization. Both p-type H–Si(111) and n-type H–Si(111) surfaces were methylated using a two-step chlorination/alkylation procedure.⁷ In a N₂ (g)-purged flush box, H–Si(111) samples were chlorinated at 90 \pm 2 °C for 45 min in a saturated solution of PCl₅ (purum, \geq 98.0%, Sigma-Aldrich) in chlorobenzene (anhydrous, 99.8%, Sigma Aldrich). Following a rinse with chlorobenzene and a subsequent rinse with tetrahydrofuran (THF, anhydrous, \geq 99.9%, inhibitor-free, Sigma Aldrich), the Cl–Si(111) surfaces were exposed to methylmagnesium chloride (3 M in THF, Sigma Aldrich, diluted to 1 M with THF) for 3–4 h at 60 ± 2 °C. The resulting CH₃–Si(111) surfaces were rinsed with THF, followed by a rinse in CH₃OH (anhydrous, 99.8%, Sigma Aldrich). The samples were removed from the flush box and were rinsed further in CH₃OH, sonicated in CH₃CN, and then rinsed with H₂O. Functionalized CH₃–Si(111) samples were diced, and electrodes were prepared immediately. Following an 8 day exposure to ambient air in the dark, X-ray photoelectron spectroscopy (XPS) verified the lack of significant of oxide formation on the CH₃–Si(111) samples (see the Supporting Information).

C. Electrode Fabrication. Ohmic contacts to the back side of the p-Si(111) electrodes that were used for differential capacitance-potential experiments were formed by evaporation of 300 nm of Al (Denton Vacuum, Moorestown, New Jersey), followed by a 30 min anneal at 450 °C under 5 vol % H_2 (g)/ 95% N_2 (g). The aluminum contact was formed prior to the chlorination/alkylation procedure, and care was taken to physically isolate the aluminum-coated side of the wafer from the side that was exposed to the chlorination and to the alkylation solutions. For both n-type and p-type electrodes that were used in the I-E studies, ohmic contacts were formed by using a diamond tipped scribe to scratch a Ga-In eutectic alloy into pieces of the Si wafer. The ohmically contacted Si samples were affixed to a tinned Cu wire by use of high purity, conductive, Ag paint (SPI Supplies, West Chester, Pennsylvania). The Cu wire was then threaded through a Pyrex tube until only the wafer face was exposed perpendicular to the tube length. The electrode was then sealed with Loctite 9460 epoxy. The exposed areas of Si(111) were $1-3 \text{ mm}^2$ for electrodes used in J-E studies and were 0.7-0.9 cm² for electrodes used in the differential capacitance-potential studies.

Prior to each photoelectrochemical experiment, H-Si(111) electrode surfaces were etched for 10 s in 6 M HF, rinsed in H_2O , dried in Ar, and immediately transferred to an Ar-purged glovebox. The $CH_3-Si(111)$ electrode surfaces were rinsed sequentially in water, methanol, isopropyl alcohol, and trichloroethylene (spectrophotometric grade, Sigma-Aldrich), dried in Ar, and transferred to the glovebox for photoelectrochemical measurements.

D. Chemicals for Photoelectrochemistry. A series of redox couples having a range of formal potentials, $E^{\circ\prime}(A/A^{-})$, was used in the electrochemical studies (Table 1). For the cobalt-containing compounds, 1,1'-dimethylcobaltocenium $(Me_2Cp_2Co^+PF_6^-, bis(methylcyclopentadienyl)cobaltocenium$ hexafluorophosphate) was synthesized from methylcyclopentadienyl lithium, cobalt(II) chloride hydrate, and potassium hexafluorophosphate.²⁰ 1,1'-Dimethylcobaltocene (Me₂Cp₂Co, bis(methylcyclopentadienyl)cobaltocene) was generated in situ via bulk electrolysis. Cobaltocene (Cp₂Co, bis-(cyclopentadienyl)cobalt(II), 98%, Strem) was purified by vacuum sublimation, whereas cobaltocenium $(Cp_2Co^+PF_6^-)$ bis(cyclopentadienyl)cobaltocenium hexafluorophosphate, 98%, Sigma-Aldrich) was recrystallized from an ethanol (ACS grade, EMD)/acetonitrile (ACS grade, EMD) mixture and was dried under vacuum. Both 1,1'-dicarbomethoxycobaltocene $((CpCO_2CH_3)_2Co, 1,1'-bis(\eta^5-methoxycarbonyl$ cyclopentadienyl)cobalt) and the oxidized $(CpCO_2CH_3)_2Co^+$

species, were synthesized by reacting $CoCl_2$ with the lithium reagent of the functionalized cyclopentadienyl moiety.^{21,22}

For the nickel-containing compounds, octamethylnickelocene (Me_8Cp_2Ni , bis(tetramethylcyclopentadienyl)nickel, 98%, Strem) and nickelocene (Cp_2Ni , bis(cyclopentadienyl)nickel, 99%, Strem) were purified by sublimation. Nickelocenium, Cp_2Ni^+ , was generated in situ via the electrolysis of Cp_2Ni . Octamethylnickelocenium ($Me_8Cp_2Ni^+BF_4^-$, bis-(tetramethylcyclopentadienyl)nickelocenium tetrafluoroborate) was synthesized by the chemical oxidation of octamethylnickelocene, and was purified by recrystallization.²³

The iron complexes, decamethylferrocene (Cp*2Fe, bis-(pentamethylcyclopentadienyl)iron, 99%, Strem), octamethylferrocene (Me₈Cp₂Fe, bis(tetramethylcyclopentadienyl)iron, 98%, Strem), 1,1'-dimethylferrocene (Me₂Cp₂Fe, bis-(methylcyclopentadienyl)iron, 95%, Sigma-Aldrich), ferrocene (Cp₂Fe, bis(cyclopentadienyl)iron, 99%, Strem), and acetylferrocene (CpCOCH₃(Cp)Fe, (acetylcyclopentadienyl)cyclopentadienyliron, 99.5%, Strem) were purified by sublimation. The salts decamethylferrocenium (Cp*2Fe+BF4-, bis(pentamethylcyclopentadienyl)ferrocenium tetrafluoroborate), octamethylferrocenium (Me₈Cp₂Fe⁺BF₄⁻, bis-(tetramethylcyclopentadienyl)ferrocenium tetrafluoroborate), and 1,1'-dimethylferrocenium (Me₂Cp₂Fe⁺BF₄⁻, bis-(methylcyclopentadienyl)ferrocenium tetrafluoroborate) were synthesized by chemical oxidation of the neutral metallocenes.²³ Ferrocenium tetrafluoroborate (Cp₂Fe⁺BF₄⁻, bis-(cyclopentadienyl)iron(III) tetrafluoroborate, technical grade, Sigma-Aldrich) was purified by recrystallization. Acetylferrocenium was generated in situ via bulk electrolysis of acetyleferrocene.

Methyl viologen (MV^{2+} , 1,1'-dimethyl-4,4'-bipyridinium dichloride hydrate, 98%, Sigma-Aldrich) was recrystallized from ethanol. The reduced form, $MV^{+\bullet}$, was generated by controlled potential electrolysis of MV^{2+} .

E. Photoelectrochemical Methods. 1. Electrochemical Cells. Current density vs potential (J-E) and area-corrected differential capacitance vs potential $(A^2C_{diff}^{-2}-E)$ data were collected in a four-port, cylindrical, flat-bottomed, borosilicate cell that contained 1.0 M LiClO₄ in 30 mL of dry CH₃CN. All experiments were performed in an Ar (g)-filled drybox that contained <0.5 ppm of O_2 (g). The reference electrode was a freshly prepared Ag⁺/Ag electrode,²⁹ that was constructed from borosilicate tubing with a Vycor 7930 porous glass frit (Advanced Glass and Ceramics, Holden, Massachusetts) that was attached to the borosilicate by Teflon heat-shrink tubing. Silver wire (0.5 mm diameter, ≥99.99%, Sigma-Aldrich) was abraded with grade 0000 steel wool, etched in 0.10 M HNO3 (aq) for 10 s, copiously rinsed with water, and transferred to the Ar(g) drybox. The filling solution consisted of ~ 1.3 mL of the 1.0 M LiClO₄ in CH₃CN and \sim 2 mg of silver nitrate (AgNO₃, 99.9999% trace metal basis, Sigma-Aldrich). During electrochemical experiments, the Nernstian potential of the solution was determined by a cyclic voltammetric (CV) measurement of the behavior of a Pt wire electrode (0.5 mm diameter, 99.99% trace metals basis, Sigma-Aldrich) vs the Ag⁺/ Ag reference electrode.²⁴

2. Redox Couples. For redox couples that were not generated by bulk electrolysis and whose concentrations were not limited by solubility considerations,²⁵ the concentrations of the redox couples were generally 50–65 mM for the species that accepted minority photocarriers and 0.5–5 mM for the species that accepted majority carriers (Table 1). Several of the

redox couples contained unstable active species that required in situ generation via bulk electrolysis, as denoted with an asterisk in Table 1. For those systems, the complementary redox species was generated at a large-area Pt gauze electrode (100 mesh, 99.9% trace metals basis, Sigma-Aldrich). Prior to use, all of the Pt electrodes were etched briefly in a 3:1 (v:v) solution of concentrated hydrochloric acid:nitric acid ("aqua regia"), rinsed with water, and thoroughly dried. The Pt gauze working electrode was scanned potentiostatically vs the Ag^+/Ag reference electrode. The counter electrode was a separate piece of Pt gauze that was located in a compartment that was isolated from the main cell by a Vycor frit.

For each redox couple A/A⁻, cyclic voltammetric scans of the Pt wire electrode relative a Ag⁺/Ag reference electrode, before and after the addition of ferrocene to the solution, were used to establish the Nernstian potential of the cell, $E(A/A^-)$, as well as the formal potential, $E^{o'}(A/A^-)$, of the redox system relative to the formal potential of ferrocene^{+/0}, $E^{o'}(ferrocene^{+/0})$ (Table 1). Cyclic voltammetry indicted that ferrocene^{+/0} with 1 M LiClO₄ in CH₃CN had a formal potential of $E^{o'}(ferrocene^{+/0}) = 0.311$ V vs a standard calomel electrode, SCE, in agreement with previous results.^{26,27} Table 1 also lists values for the effective solution potential, $E_{\text{eff}}(A/A^-)$, that was necessary for the investigation of the dependence of the open-circuit voltage, $V_{oc'}$ on $E(A/A^-)$.²⁸ The Supporting Information section details the calculation of $E_{\text{eff}}(A/A^-)$ based on the value of $E(A/A^-)$ and the concentrations of reduced and oxidized species in each system.

3. Methods. Photoelectrochemical experiments consisted of current-potential sweeps of the Si working electrode versus the Pt wire electrode that was poised at the Nernstian potential, $E(A/A^-)$, of the cell. The J-E data were collected at 50 mV s⁻¹ by use of a Gamry Reference 600 potentiostat. Si samples were illuminated with a 300 W ELH-type tungsten-halogen lamp at a light intensity that produced a shortcircuit current density on a calibrated Si photodiode equivalent to that produced by illumination with 100 mW cm⁻² of Air Mass 1.5 Global sunlight. Open-circuit voltage, V_{oct} data were directly measured as the photovoltage produced between the semiconductor working electrode and an electrode that was poised at the Nernstian potential of the solution, $E(A/A^-)$, as is appropriate for a two-electrode regenerative photoelectrochemical cell that utilizes one-electron, reversible redox species in the electrolyte.

Area-corrected differential capacitance-potential $(A^2C_{diff}^{-2}-$ E, Mott-Schottky)^{29,30} data of H-terminated and CH_3 terminated Si(111)/liquid junctions were obtained by the use of electrochemical impedance spectroscopy. Impedance spectra for CH₃-terminated and H-terminated p-Si(111) electrodes in contact with 1,1'-dicarbomethoxycobaltocene+/0 in CH3CN-1.0 M LiClO₄ were acquired with the Gamry potentiostat. Impedance data were also recorded for CH₃-terminated and Hterminated electrodes n-Si(111) electrodes in contact with octamethylferrocene^{+/0} in CH₃CN-1.0 M LiClO₄. A sinusoidal, 10 mV_{RMS} AC signal that was scanned between 10⁻¹ and 10⁶ Hz was superimposed on each DC potential. The DC potentials were stepped between 0 and -0.500 V for p-Si electrodes and in a sequence from 0 to 0.400 V for n-Si electrodes. All measurements were performed in stirred solutions in the absence of illumination.

The electrochemical impedance data were fit to a model that consisted of a parallel resistor and capacitor arranged electrically in series with a separate resistor.^{4,29,30} Analysis of the impedance data was performed using a custom LabVIEW

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program. Data were fit only in the frequency regime in which the parallel capacitance dominated the impedance, generally between 10³ and 10⁵ Hz. The differential capacitance, C_{diff} , approximated the capacitance of the semiconductor spacecharge region, C_{sc} , yielding the flat-band potential, E_{fb} , through the Mott–Schottky relationship, eq 1.

$$A^{2}C_{\rm diff}^{-2} = \frac{2}{q\varepsilon\varepsilon_{0}N_{\rm D}} \left(E - E_{\rm fb} - \frac{k_{\rm B}T}{q} \right)$$
(1)

In eq 1, A is the area of the semiconductor-liquid junction, ϵ is the dielectric constant of Si, ϵ_0 is the permittivity of vacuum, N_D is the doping density of the sample, T is the absolute temperature, k_B is Boltzmann's constant, and q is the (unsigned) charge on an electron.

III. RESULTS

A. Current–Potential Behavior of H-Terminated vs CH₃-Terminated Si Electrodes in Contact with Various Redox Couples in CH₃CN. Figure 1 presents representative

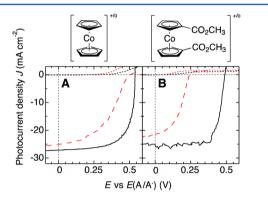


Figure 1. Photocurrent density-potential (J-E) performance of p-Si electrodes in contact with cobaltocene^{+/0} (frame A) and in contact with 1,1'-dicarbomethoxycobaltocene^{+/0} (frame B) in CH₃CN-1.0 M LiClO₄. In contact with cobaltocene^{+/0} (frame A), both a H-terminated (black, solid trace) and a CH₃-terminated (red, dashed trace) p-Si electrode exhibited high V_{oc} values. Conversely, contact with 1,1'-dicarbomethoxycobaltocene^{+/0} resulted in decreased V_{oc} values for CH₃-terminated p-Si(111) compared to the V_{oc} for H-terminated p-Si(111) surfaces. In both frames, the black and red dotted traces represent the J-E response in the absence of illumination for the H-terminated and CH₃-terminated p-Si(111) electrodes, respectively.

J-E data for selected p-Si(111) semiconductor-liquid junctions under 100 mW cm⁻² of ELH-type illumination. In contact with CH₃CN-CoCp₂^{+/0}, p-type H–Si(111) and p-type CH₃– Si(111) electrodes exhibited rectifying behavior, showing cathodic photocurrent, and showing significant anodic current in the dark only at positive potentials vs $E(A/A^-)$. Under the specified illumination conditions, the p-type H–Si(111) electrode exhibited an open-circuit voltage V_{oct} of 538 mV, whereas V_{oc} = 504 mV for the p-type CH₃–Si(111) electrode (Figure 1A). In contrast, in contact with CH₃CN-1,1'dicarbomethoxycobaltocene^{+/0}, the p-type H–Si(111) electrodes exhibited V_{oc} = 489 mV while the p-type CH₃–Si(111) electrode yielded V_{oc} = 202 mV (Figure 1B).

Figure 2 presents representative J-E data for n-type Si electrodes. In contact with CH₃CN-acetylferrocene^{+/0}, n-type H-Si(111) and n-type CH₃-Si(111) electrodes exhibited rectifying behavior, showing anodic photocurrent and showing

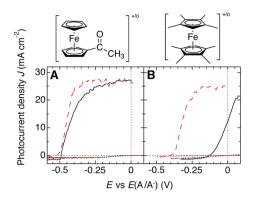


Figure 2. J-E behavior for n-Si electrodes in contact with acetylferrocene^{+/0} (frame A) and in contact with octamethylferrocene^{+/0} (frame B) in CH₃CN-1.0 M LiClO₄. In contact with acetylferrocene^{+/0} in frame A, both a H-terminated (black, solid trace) and a CH₃-terminated (red, dashed trace) n-Si electrode exhibited high $V_{\rm oc}$ values. Conversely, contact with octamethylferrocene^{+/0} resulted in a larger $V_{\rm oc}$ value for CH₃-terminated n-Si(111) compared to the $V_{\rm oc}$ for the H-terminated n-Si(111) surfaces. In both frames, the black and red dotted traces represent the J-E response in the absence of illumination for the H-terminated and CH₃-terminated p-Si(111) electrodes, respectively.

significant cathodic current in the dark only at negative potentials vs $E(A/A^-)$. For the system in Figure 2, the n-type H–Si(111) electrode exhibited $V_{oc} = -495$ mV, whereas the n-type CH₃–Si(111) electrode exhibited $V_{oc} = -525$ mV (frame A). In contrast, in contact with CH₃CN–octamethylferro-cene^{+/0}, the n-type CH₃–Si(111) electrode exhibited a $V_{oc} = -406$ mV but the n-type H–Si(111) electrode showed $V_{oc} = -129$ mV (frame B).

Figure 3 presents the dependence of V_{oc} on the effective solution potential, $E_{eff}(A/A^-)$, for p-type CH_3 –Si(111) (black, open squares), p-type H–Si(111) (green, filled squares), n-type CH_3 –Si(111) (red, open circles), and n-type H–Si(111) (blue, filled circles) in contact with 1.0 M LiClO₄–CH₃CN under 100 mW cm⁻² of ELH-simulated AM 1.5 illumination. Each point represents an average of at least 5 electrodes with values and standard deviations listed in Table 1. To highlight the observed trends for each series of electrodes, the empirically determined guide lines included in Figure 3 separately denote the region of low V_{oc} ; a region over which V_{oc} scaled approximately linearly with $E_{eff}(A/A^-)$, with a slope of 1; and a region of maximized V_{oc} in which V_{oc} was independent $E_{eff}(A/A^-)$.³¹

B. Differential Capacitance–Potential Behavior. Figure 4 plots the electrode area-corrected differential capacitance vs potential $(A^2C_{\text{diff}}^{-2}-E)$ response for n-type H–Si(111) and n-type CH₃–Si(111) electrodes in contact with octamethylferrocene^{+/0}–1.0 M LiClO₄–CH₃CN (frame A) as well as for p-type H-Si(111) and p-type CH₃-Si(111) electrodes in contact with 1,1'-dicarbomethoxycobaltocene^{+/0}-1.0 M LiClO₄-CH₃CN (frame B). The flat-band potential, $E_{\rm fb}$, was determined using the x-intercept extrapolation in Figure 4, in conjunction with eq 1. For the n-type Si electrodes (frame A), $E_{\rm fb}$ shifted from -271mV vs $E(\text{octamethylferrocene}^{+/0})$ for the H–Si(111) electrode to -660 mV vs $E(\text{octamethylferrocene}^{+/0})$ for the CH₃-Si(111) electrode. The average shift in $E_{\rm fb}$ for three electrodes of n-type H-Si(111) relative to the $E_{\rm fb}$ value for three electrodes of n-type CH₃-Si(111) electrodes in octamethylferrocene^{+/0}–1.0 ${\rm \tilde{M}}$ LiClO₄–CH₃CN was –0.40 V. For the p-Si electrodes in Figure 4B, $E_{\rm fb}$ shifted from 679 mV vs E(1,1'- dicarbomethoxycobaltocene^{+/0}) for the H–Si(111) electrode to

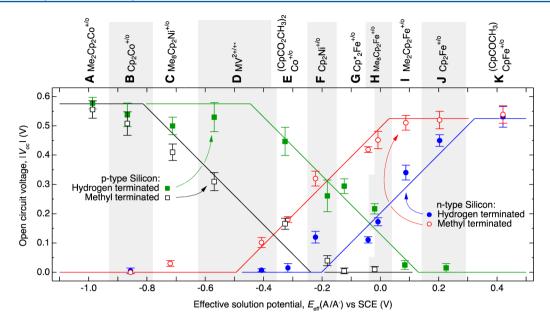


Figure 3. Open-circuit voltage, V_{ocr} vs effective solution redox potential, $E_{eff}(A/A^-)$, in CH₃CN-1.0 M LiClO₄ for H-terminated p-Si(111) (green, solid squares), CH₃-terminated p-Si(111) (black, hollow squares), H-terminated n-Si (blue, solid squares), and CH₃-terminated n-Si(111) (red, hollow squares) electrodes. The corresponding lines serve as guides to indicate the observed trends in the different regions of V_{oc} vs $E_{eff}(A/A^-)$ behavior.

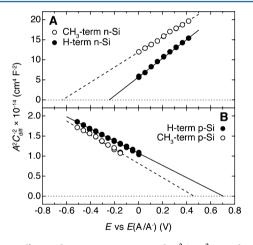


Figure 4. Differential capacitance–potential, $A^2 C_{\rm diff}^{-2}-E$, relationships for n-Si(111) electrodes in octamethylferrocene^{+/0} (frame A) and p-Si(111) electrodes in 1,1'-dicarbomethoxycobaltocene^{+/0} (frame B) for H-terminated electrodes (solid circles, solid linear extrapolation to $A^2 C_{\rm diff}^{-2} = 0 \text{ cm}^4 \text{ F}^{-2}$) and CH₃-terminated electrodes (open circles, dashed linear extrapolation to $A^2 C_{\rm diff}^{-2} = 0 \text{ cm}^4 \text{ F}^{-2}$). The change in potential values in the extrapolation to $A^2 C_{\rm diff}^{-2} = 0 \text{ cm}^4 \text{ F}^{-2}$ corresponds to a negative shift in the flat-band potential for CH₃terminated Si(111) electrodes relative to the flat band potential of Hterminated Si(111) electrodes in contact with these selected redox systems.

437 mV vs E(1,1'-dicarbomethoxycobaltocene^{+/0}) for the CH₃-Si(111) electrode. The average shift in $E_{\rm fb}$ for three electrodes of p-type H–Si(111) relative to the $E_{\rm fb}$ for three electrodes of p-type CH₃-Si(111) in 1,1'-dicarbomethoxycobaltocene^{+/0}-1.0 M LiClO₄-CH₃CN was 0.25 V.

IV. DISCUSSION

Upon functionalization of the surface, a change in the opencircuit photovoltage of a photoelectrode in contact with an single redox system could indicate a shift in the interfacial dipole, a change in the surface recombination rate, and/or a change in the position of the surface Fermi level due to Fermi level pinning. However, the systematic shift in V_{oc} observed herein for a series of electrochemically reversible, one-electron transfer, outer-sphere, redox couples (Figure 3) strongly indicates that a change in the magnitude of the interfacial dipole is the predominant electrical effect that accompanies a change in the chemical termination of the Si(111) surface from H- to CH_3 - moieties. This hypothesis is consistent with the observation that the photovoltage exhibits nearly identical maximal limiting values at very positive values of $E(A/A^{-})$ for the n-type electrodes of both functionality, and exhibits similar maximal limiting values at very negative values of $E(A/A^{-})$ for the p-type Si electrodes.³¹ Furthermore, the potential shift of the band-edges observed in selected cases by the $A^2 C_{\text{diff}}^{-2} - E$ measurements (Figure 4) unambiguously indicates that the interfacial dipole has been modified by the surface functionalization procedure. The observation of the dependence of V_{oc} on $E(A/A^{-})$ for a wide range of Nernst potentials of the solution indicates that the functionalization has not also introduced deleterious increases in the rates of surface recombination processes nor has deleteriously affected the rates of interfacial minority-carrier transfer to the redox species in the electrolyte. The CH₃- functionalization thus for all practical purposes yields the same, nearly ideal, electrical behavior that is characteristic of H-Si(111) surfaces but with a shift in the interfacial dipole, and thus in the band-edge positions, for CH₃-Si(111) surfaces, along with improved resistance to chemical and electrochemical oxidation processes that accompanies the replacement of Si-H bonds by surficial Si-C bonds. For a given value of $E(A/A^{-})$, the shift in interfacial dipole produces larger photovoltages for n-type Si photoelectrodes and smaller photovoltages for p-type Si photocathodes, until the limiting regimes of maximal $V_{\rm oc}$ (or minimal $V_{\rm oc}$) are reached at very negative or at very positive potentials, respectively (Figure 3).

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From the impedance experiments, the shift in $E_{\rm fb}$ due to surface methylation was -0.40 V for n-Si(111) electrodes in contact with octamethylferocene^{+/0}-CH₃CN and -0.25 V for p-Si(111) electrodes in contact with 1,1'-dicarbomethoxycobaltocene^{+/0}-CH₃CN, relative to the $E_{\rm fb}$ behavior of the respective H-Si(111) electrode surfaces. The magnitude of this $E_{\rm fb}$ shift is broadly consistent with the -0.3 V shift in the guide lines in Figure 3 between the V_{oc} trends for CH₃-Si(111) and H-Si(111) electrodes. The flat-band shifts observed for the Si/ CH₃CN junctions are somewhat smaller than the \sim -0.49 eV dipole energy shift that has been reported between CH₃-Si(111) and H-Si(111) surfaces in ultrahigh vacuum as measured by photoelectron spectroscopy.^{9,15-17} Shifts of ~ -0.55 eV in the band-edge positions have been inferred from measurements of changes in the barrier heights of silicon/ mercury contacts.⁴ The reduction in the magnitude of the interfacial dipole at semiconductor/liquid contacts relative to ultrahigh vacuum experiments is consistent with a partial screening of the dipole by the electrolyte and/or inherent shifts in the band-edge positions of Si in contact with an electrolyte relative to the band-edge positions in contact with UHV.

The sign and approximate magnitude of the interfacial dipole that results from H– or CH_3 – termination has been evaluated theoretically.¹⁸ Broadly, the sign of the interfacial dipole is in accord with the electronegativity differences between Si and either H– or CH_3 – moieties. Using both density functional theory and many-body perturbation theory, specifically the perturbative G_oW_o approach, a band-edge shift of –0.8 eV has been predicted for CH_3 –Si(111) surfaces relative to H– Si(111) surfaces in contact with vacuum and thus in the absence of solvation or specific adsorption.¹⁸ The sign and magnitude of the interfacial dipole layer indicated by the data described herein is therefore consistent with theoretical expectations for this type of surface functionalization process.

The band-edge shift that accompanies CH₃-termination of Si(111) is advantageous for some applications and disadvantageous for others. For example, with a given redox system, the shift that results from CH_3 -termination of Si(111) is expected to produce higher barrier heights and thus higher photovoltages and better rectification, for n-Si(111) photoanodes, but also is expected to result in poorer ohmic contacts between a low work function conducting polymer, such as poly(3,4-ethylenedioxythiophene)/poly(styrenesulfonate) (PEDOT/PSS) and n-type CH3-terminated Si(111) surfaces.32 Similarly, the band-edge shift introduced by CH3-termination will produce better ohmic contacts, but smaller photovoltages, for photocathodes that are formed from CH₃-functionalized p-Si(111) electrodes relative to photocathodes formed from H-terminated p-Si(111) electrodes.³³ The improved oxidation resistance upon functionalization of Si(111) with methyl groups³⁴ thus is accompanied by a decrease in the photoelectrochemical performance of Si(111) surfaces for photocathodic proton reduction in solar-driven water-splitting systems.³ These expectations are in accord with experimental observations on H-Si(111) vs CH₃-Si(111) electrodes to date.^{14,33,34} Hence, alternate routes to surface functionalization that shift the bandedge positions positively and/or the use of buried p-n⁺ junctions^{35,36} will be required to combine the improved stability with improvements in open-circuit photovoltages upon functionalization of p-Si(111) photocathodes.

V. CONCLUSIONS

For a given solution redox potential, CH_3 -terminated p-Si(111) electrodes showed lower $V_{\rm oc}$ values than H-terminated p-Si(111) electrodes, whereas CH₃-terminated n-type Si(111) electrodes showed higher $V_{\rm oc}$ values than H-terminated n-Si(111) electrodes. Differential capacitance-potential experiments confirmed that differences between the flat-band potentials of CH3-Si(111) electrodes and H-Si(111) yielded the respective V_{oc} vs $E(A/A^-)$ behavior. The observed changes in flat-band potential are consistent with a negative shift in the interfacial dipole as a result of methylation of the Si(111)surface and indicate that, relative to the behavior of H-Si(111)electrodes, methylation of Si(111) increases the rectifying behavior at n-type Si/liquid junctions and increases the ohmic behavior of p-type Si/liquid junctions. The shift in flat-band potential observed electrochemically is fully consistent with the shift in interfacial dipole observed by photoemission in ultrahigh vacuum, as well as by the electrical behavior of Si/ Hg contacts and additionally as predicted theoretically by density functional theory.

ASSOCIATED CONTENT

S Supporting Information

Calculation of effective solution potential, $E_{\text{eff}}(A/A^-)$, and Xray photoelectron spectra quantifying the degree of oxidation on the methylated Si(111) surfaces. This material is available free of charge via the Internet at http://pubs.acs.org.

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Notes

The authors declare no competing financial interest.

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REFERENCES

- (1) Tan, M. X.; Laibinis, P. E.; Nguyen, S. T.; Kesselman, J. M.; Stanton, C. E.; Lewis, N. S. Prog. Inorg. Chem. **1994**, 41, 21.
- (2) Bard, A. J.; Faulkner, L. R. *Electrochemical Methods: Fundamentals and Applications*, 2nd ed.; Wiley: New York, 2001.
- (3) Walter, M. G.; Warren, E. L.; McKone, J. R.; Boettcher, S. W.; Mi,
- Q. X.; Santori, E. A.; Lewis, N. S. Chem. Rev. 2010, 110, 6446.
 (4) Maldonado, S.; Plass, K. E.; Knapp, D.; Lewis, N. S. J. Phys. Chem. C 2007, 111, 17690.
- (5) Webb, L. J.; Nemanick, E. J.; Biteen, J. S.; Knapp, D. W.;
 Michalak, D. J.; Traub, M. C.; Chan, A. S. Y.; Brunschwig, B. S.; Lewis,
 N. S. J. Phys. Chem. B 2005, 109, 3930.
- (6) Webb, L. J.; Rivillon, S.; Michalak, D. J.; Chabal, Y. J.; Lewis, N. S. J. Phys. Chem. B 2006, 110, 7349.
- (7) Bansal, A.; Li, X. L.; Lauermann, I.; Lewis, N. S.; Yi, S. I.; Weinberg, W. H. J. Am. Chem. Soc. **1996**, 118, 7225.
- (8) Bansal, A.; Li, X. L.; Yi, S. I.; Weinberg, W. H.; Lewis, N. S. J. Phys. Chem. B 2001, 105, 10266.

(9) Hunger, R.; Fritsche, R.; Jaeckel, B.; Jaegermann, W.; Webb, L. J.; Lewis, N. S. *Phys. Rev. B* **2005**, 72.

The Journal of Physical Chemistry C

(10) Yu, H. B.; Webb, L. J.; Ries, R. S.; Solares, S. D.; Goddard, W. A.; Heath, J. R.; Lewis, N. S. J. Phys. Chem. B **2005**, 109, 671.

(11) Royea, W. J.; Juang, A.; Lewis, N. S. Appl. Phys. Lett. 2000, 77, 1988.

(12) Hunger, R.; Fritsche, R.; Jaeckel, B.; Webb, L. J.; Jaegermann, W.; Lewis, N. S. Surf. Sci. 2007, 601, 2896.

(13) Jaeckel, B.; Hunger, R.; Webb, L. J.; Jaegermann, W.; Lewis, N. S. J. Phys. Chem. C 2007, 111, 18204.

(14) Bansal, A.; Lewis, N. S. J. Phys. Chem. B 1998, 102, 1067.

(15) Akremi, A.; Lacharme, J. P.; Sebenne, C. A. Surf. Sci. 1998, 404, 746.

(16) Hunger, R.; Pettenkofer, C.; Scheer, R. J. Appl. Phys. 2002, 91, 6560.

(17) Hollinger, G.; Himpsel, F. J. J. Vac. Sci. Technol. A 1983, 1, 640. (18) Li, Y.; O'Leary, L. E.; Lewis, N. S.; Galli, G. Energy Environ. Sci., submitted.

(19) Kern, W. Overview and Evolution of Silicon Wafer Cleaning Technology. In *Handbook of Silicon Wafer Cleaning Technology*, 2nd ed.; Reinhardt, K. A., Kern, W., Eds.; William Andrew Publishing, 2008.

(20) Inyushin, S.; Shafir, A.; Sheats, J. E.; Minihane, M.; Whitten, C. E.; Arnold, J. *Polyhedron* **2004**, *23*, 2937.

(21) Hart, W. P.; Macomber, D. W.; Rausch, M. D. J. Am. Chem. Soc. 1980, 102, 1196.

(22) Sheats, J. E.; Rausch, M. D. J. Org. Chem. 1970, 35, 3245.

(23) Hendrickson, D. N.; Sohn, Y. S.; Gray, H. B. Inorg. Chem. 1971, 10, 1559.

(24) Smith, T. J.; Stevenson, K. J. Reference Electrodes. In *Handbook* of *Electrochemistry*; Zoski, C. G., Ed.; Elsevier: Amsterdam, 2007.

(25) Robbins, J. L.; Edelstein, N.; Spencer, B.; Smart, J. C. J. Am. Chem. Soc. 1982, 104, 1882.

(26) Connelly, N. G.; Geiger, W. E. Chem. Rev. 1996, 96, 877.

(27) Kuwana, T.; Bublitz, D. E.; Hoh, G. J. Am. Chem. Soc. 1960, 82, 5811.

(28) Rosenbluth, M. L.; Lewis, N. S. J. Phys. Chem. 1989, 93, 3735.

(29) Fajardo, A. M.; Lewis, N. S. J. Phys. Chem. B 1997, 101, 11136.

(30) Gstrein, F.; Michalak, D. J.; Knapp, D. W.; Lewis, N. S. J. Phys. Chem. C 2007, 111, 8120.

(31) Lewis, N. S. J. Electrochem. Soc. 1984, 131, 2496.

(32) Yahyaie, I.; McEleney, K.; Walter, M. G.; Oliver, D. R.; Thomson, D. J.; Freund, M. S.; Lewis, N. S. J. Phys. Chem. C 2011, 115, 24945.

(33) Johansson, E.; Boettcher, S. W.; O'Leary, L. E.; Poletayev, A. D.; Maldonado, S.; Brunschwig, B. S.; Lewis, N. S. J. Phys. Chem. C 2011, 115, 8594.

(34) Hamann, T. W.; Lewis, N. S. J. Phys. Chem. B 2006, 110, 22291. (35) Warren, E. L.; Boettcher, S. W.; Walter, M. G.; Atwater, H. A.;

Lewis, N. S. J. Phys. Chem. C 2011, 115, 594.

(36) Boettcher, S. W.; Warren, E. L.; Putnam, M. C.; Santori, E. A.; Turner-Evans, D.; Kelzenberg, M. D.; Walter, M. G.; McKone, J. R.; Brunschwig, B. S.; Atwater, H. A.; Lewis, N. S. *J. Am. Chem. Soc.* **2011**, 133, 1216.